





TEST REPORT

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Report Number: FCC ID:

Test Standard (s)

FCC PART 2.1093, FCC PART 1.1307

Sample Description

Product Type:	Smart phone		
Model No.:	PG4RBG100		
Multiple Model(s) No.:	PG4RB100A		
Trade Mark:	UMIDIGI		
Date Received:	2024-10-17		
Issue Date:	2024-12-05		

Test Result: Pass▲

 \blacktriangle In the configuration tested, the EUT complied with the standards above.

Prepared and Checked By:

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Jim Cheng RF Engineer

Approved By:

Wans

Nancy Wang RF Supervisor

Note: The information marked[#] is provided by the applicant, the laboratory is not responsible for its authenticity and this information can affect the validity of the result in the test report. Customer model name, addresses, names, trademarks etc. are included.

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Bay Area Compliance Laboratories Corp. (Shenzhen)

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Version 4.0

Bay Area Compliance Laboratories Corp. (Shenzhen)

Report No.: 2401Y99438E-RF-00D

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DOCUMENT REVISION HISTORY

Revision Number	Number Report Number Description of Revision		Date of Revision	
0	2401Y99438E-RF-00D	Original Report	2024-12-05	

GENERAL INFORMATION

Product Description for Equipment under Test (EUT)

Product	Smart phone			
Tested Model	PG4RBG100			
Multiple Model(s) No.	PG4RB100A			
Frequency Range	Bluetooth /BLE: 2402~2480MHz			
Maximum Conducted Output Peak Power	Bluetooth: 0.18dBm, BLE: 1.22dBm			
Modulation Technique	Bluetooth: GFSK, π/4-DQPSK, 8DPSK BLE: GFSK			
Antenna Specification [#]	1.38dBi (provided by the applicant)			
Voltage Range	DC 5V/9V/12V charging from Adapter or DC 3.89V from battery			
Sample serial number	2SY1-1 (Assigned by BACL, Shenzhen)			
Sample/EUT Status	Good condition			
Adapter Information Model: QZ-02002AC00 Input: AC100-240V, 50/60Hz, 0.5A Output: DC 5.0V, 3.0A(15.0W) or DC 9.0V, 2.22A or DC 12.0' 1.67A(20.0W Max.) Output: DC 5.0V, 3.0A(15.0W)				
Note: The Multiple models are electrically identical with the test model except for model name and sales				
channels. Please refer to the declaration letter [#] for more detail, which was provided by manufacturer.				

channels. Please refer to the declaration letter[#] for more detail, which was provided by manufacturer.

Objective

This report is in accordance with FCC Part 2.1093 and 1.1307 rules.

Test Facility

The Test site used by Bay Area Compliance Laboratories Corp. (Shenzhen) to collect test data is located on the 5F(B-West), 6F, 7F, the 3rd Phase of Wan Li Industrial Building D, Shihua Rd, FuTian Free Trade Zone, Shenzhen, China.

The lab has been recognized as the FCC accredited lab under the KDB 974614 D01 and is listed in the FCC Public Access Link (PAL) database, FCC Registration No. : 715558, the FCC Designation No. : CN5045.

Bay Area Compliance Laboratories Corp. (Shenzhen)

RF EXPOSURE EVALUATION

RF EXPOSURE

Applicable Standard

According to FCC §2.1093 and §1.1307(b) (1), systems operating under the provisions of this section shall be operated in a manner that ensure that the public is not exposed to radio frequency energy level in excess of the Commission's guideline.

According to KDB 447498 D01 General RF Exposure Guidance v06

The 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances \leq 50 mm are determined by:

[(max. power of channel, including tune-up tolerance, mW)/(min. test separation distance, mm)] • $[\sqrt{f(GHz)}] \le 3.0$ for 1-g SAR and ≤ 7.5 for 10-g extremity SAR, where

1. f(GHz) is the RF channel transmit frequency in GHz.

2. Power and distance are rounded to the nearest mW and mm before calculation.

3. The result is rounded to one decimal place for comparison.

4. When the minimum test separation distance is < 5 mm, a distance of 5 mm is applied to determine SAR test Exclusion.

Measurement Result

For worst case:

Mode	Frequency (MHz)	Max tune-up conducted power [#] (dBm)	Max tune-up conducted power [#] (mW)	Distance (mm)	Calculated value	Threshold (1-g SAR)	SAR Test Exclusion
BT	2402-2480	0.5	1.12	5	0.4	3.0	Yes
BLE	2402-2480	1.5	1.41	5	0.4	3.0	Yes

Result: Compliant

Bay Area Compliance Laboratories Corp. (Shenzhen)

EUT PHOTOGRAPHS

Please refer to the attachment 2401Y99438E-RF External photo and 2401Y99438E-RF Internal photo.

***** END OF REPORT *****

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